

Notice of References Cited	Application/Control No. 10/644,172	Applicant(s)/Patent Under Reexamination CHAN ET AL.	
	Examiner William J. Klimowicz	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,788,493	09-2004	Subramaniam et al.	360/97.02
*	B	US-6,898,048	05-2005	Adams et al.	360/97.02
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

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	O	JP 2002133827 A	05-2002	Japan	NAKAMOTO et al.	
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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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